L Number	Hits		DB	Time stamp
-	7	valence adj band and conduction adj band	USOCR	2002/12/06 18:27
		and semiconductor same testing		
-	1	2790952.URPN.	USPAT	2002/12/06 18:42
-	6	3493767.URPN.	USPAT	2002/12/06 18:43
-	4	valence adj band and conduction adj band	EPO; JPO;	2002/12/06 18:47
		and semiconductor same testing	DERWENT;	
			IBM TDB	
-	39	valence adj band and conduction adj band	USPĀT;	2002/12/06 19:25
		and semiconductor same testing	US-PGPUB	
-	8	(valence adj band and conduction adj band	USPAT;	2002/12/06 19:26
		and semiconductor same testing) and	US-PGPUB	
		324/\$.ccls.		
-	0	20020021141.URPN.	USPAT	2002/12/06 19:39
-	3	("4051437" "4287473" "4333051").PN.	USPAT	2002/12/06 19:40
-	14	4599558.URPN.	USPAT	2002/12/06 19:41
-	9	measuring same conduction same valence	USOCR	2002/12/06 20:02
		same gap same band		
-	2	measuring same conduction same valence	EPO; JPO;	2002/12/06 20:02
		same gap same band	DERWENT;	
			IBM TDB	
-	7	measuring same conduction same valence	USPAT;	2002/12/06 20:04
		same gap same band	US-PGPUB	

Page 1